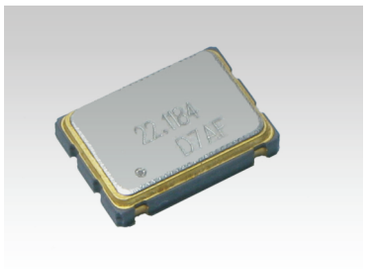
Oscillator SMD, programmable

APQO 7050

Features:

RoHS 2002/95/EC

- Small size 7x5mm
- Low cost to performance
- 3.0 ~ 5.5 volt available
- Tolerance and stability to ±25ppm
- Ultra low jitter <11ps
- Tristate or power down available

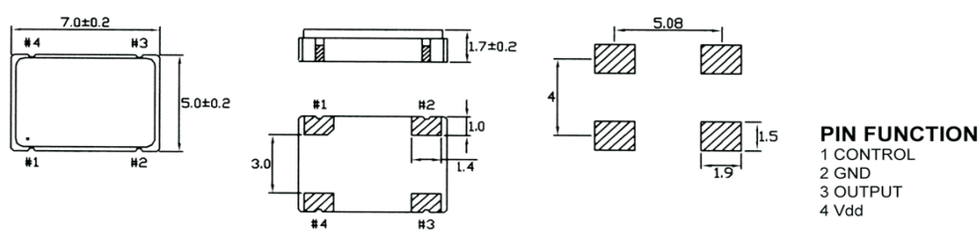


Specifications			
		APQO 7050	*Remarks*
Frequency range		1MHz ~ 133MHz	Please specify
Frequency stability		±25ppm ~ ±100ppm	Please specify
Operating temperature		0°C ~ +70°C - -40°C ~ +85°C	Please specify
Storage temperature		-55°C ~ +125°C	
Programmable voltage	1 ~ 133 MHz	5.0V ±10%	
Programmable voltage	1 ~ 100 MHz	3.3V ±10%	
Aging (ppm / Year), Ta = 25C, Vdd = 5 / 3.3 V		±5ppm	
Programmable output level		CMOS / TTL	

Operating conditions				
		Min	Max	Unit
Vdd	Supply voltage	3.0	5.5	V
CTTL	Max capacitive load on outputs for TTL levels			25
	4.5 V ~ 5.5 V Vdd 40 MHz		50	pF
	4.5 V ~ 5.5 V Vdd > 40 ~ 133 MHz		25	pF
CCMOS	Max capacitive load on outputs for CMOS levels			
	4.5 V ~ 5.5 V Vdd 66 MHz		50	pF
	4.5 V ~ 5.5 V Vdd > 66 ~ 133 MHz		25	pF
	3.0 V ~ 3.6 V Vdd 40 MHz		30	pF
	3.0 V ~ 3.6 V Vdd > 40 ~ 100 MHz		15	pF

Drawing

APQO 7050



PIN FUNCTION
1 CONTROL
2 GND
3 OUTPUT
4 Vdd

Dimensions in mm

Order key							
O	**- 10.000000M**	**- APQO 7050**	**- 50**	**- 5.0**	**- A**	**/ T**	**/**
Part	**Frequency**	**Type/Package**	**Tolerance**	**Voltage**	**Temperature**	**Option**	**Packaging**
O=Oscillator	M=MHz	APQO= programmable QO 7050=SMD 7x5	±ppm	5.0=5.0Volt 3.3=3.3Volt	A= 0°C ~ +70°C B= -10°C ~ +60°C C= -10°C ~ +70°C D= -20°C ~ +70°C E= -40°C ~ +85°C	T= Tristate P = Power down	blank = tube

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APQO 7050

Electrical characteristics					
	Test conditions	Min	Typ	Max	Unit
Input characteristics (Pin 1):					
V_{IL}, Low-level input voltage	4.5 ~ 5.5 V Vdd			0.8	V
TO Tri-state or power down	3.0 ~ 3.6 V Vdd			0.2 Vdd	V
V_{IH}, High-level iInput voltage	4.5 ~ 5.5 V Vdd	2.0			V
TO Enable output or no connect	3.0 ~ 3.6 V Vdd	0.7 Vdd			V
I_{IL}, Input low current	V_{IN} = 0V			10	µA
I_{IH}, Input high current	V_{IN} = Vdd			5	µA
Input characteristics	4.5 V ~ 5.5 V Vdd, 16 mA I_{OL}			0.4	V
V_{OL}, Low-level output voltage	3.0 V ~ 3.6 V Vdd, 8 mA I_{OL}			0.4	V
V_{OHTTL}, High-level output voltage TTL	4.5 V ~ 5.5 V Vdd, -16 mA I_{OL}	2.4			V
V_{OHCMOS}, High-level CMOS voltage	4.5 ~ 5.5 Vdd, -16 mA I_{OL}	Vdd - 0.4			V
	3.0 V ~ 3.6 V Vdd, -8 mA I_{OL}	Vdd - 0.4			V
Power supply current	4.5 ~ 5.5 Vdd, Output-freq 133 MHz			45	mA
(unloaded)	3.0 ~ 3.6 Vdd, Output-freq 100 MHz			25	mA
Standby current			10	50	µA
Input pull-up resistor	4.5 ~ 5.5 Vdd, V_{IN} = 0V	1.1	3.0	8.0	M
(P_{IN} 1)	4.5 ~ 5.5 Vdd, V_{IN} = 0.7 V	50	100	200	K
Tri-state leakage current	5.0 Vdd		20		µA
Output enable mode	Output is Tri-stated				
Power down mode	Output is Tri-stated				

Output clock switching characteristics					
Description	Test conditions	Min	Typ	Max	Unit
Duty cycle					
TTL @ 1.4 V	50 MHz, C_L = 50 pF	45		55	%
4.5 ~ 5.5 Vdd	50 ~ 66 MHz, C_L = 15 pF	45		55	%
	66 ~ 125 MHz, C_L = 25 pF	40		60	%
	125 ~ 133 MHz, C_L = 15 pF	40		60	%
Duty cycle:					
CMOS @ Vdd / 2	66 MHz, C_L 25 pF	45		55	%
4.5 ~ 5.5 Vdd	66 ~ 125 MHz, C_L 25 pF	40		60	%
3.0 ~ 3.6 Vdd	125 ~ 133 MHz, C_L 15 pF	40		60	%
	40 MHz, C_L 30 pF	45		55	%
	40 ~ 100 MHz, C_L 15 pF	40		60	%
Output clock rise / fall	0.8 V ~ 2.0 V, 4.5 ~ 5.5 Vdd, C_L = 50			1.8	ns
	0.8 V ~ 2.0 V, 4.5 ~ 5.5 Vdd, C_L = 25			1.2	ns
	0.8 V ~ 2.0 V, 4.5 ~ 5.5 Vdd, C_L = 15			0.9	ns
	0.2 ~ 0.8 Vdd, 4.5 ~ 5.5 Vdd, C_L = 50			3.4	ns
	0.2 ~ 0.8 Vdd, 3.0 ~ 3.6 Vdd, C_L = 30			4.0	ns
	0.2 ~ 0.8 Vdd, 3.0 ~ 3.6 Vdd, C_L = 15			2.4	ns
Start up time	From power on			2	ms
Power down delay time					
Synchronous	PWR_DWN pin LOW to output Hi-Z		T / 2	T+10	ns
Asynchronous			10	15	ns
Output disable time					
Synchronous	OE pin LOW to output Hi-Z		T / 2	T+10	ns
Asynchronous	T = Frequency oscillator period		10	15	ns
Output enable time				100	ns
Period Jitter:	1 - 133MHz		8	11	ps
Peak to peak	33.000 MHz		65	99	ps
	> 33.000 MHz		65	80	ps